

Search Notes

Application/Control No.

10/669,887

Examiner

Eric F. Winakur

Applicant(s)/Patent under
Reexamination

CHENG ET AL.

Art Unit

3736

SEARCHED

Class	Subclass	Date	Examiner
600	310, 322, 328, 336, 473, 475	7/12/2005	EFW
600	476	7/12/2005	EFW
356	39, 41	7/12/2005	EFW
250	339.01	7/12/2005	EFW
250	339.02	7/12/2005	EFW
250	339.05	7/12/2005	EFW
250	339.06	7/12/2005	EFW
250	339.11	7/12/2005	EFW
250	340	7/12/2005	EFW
250	341.1	7/12/2005	EFW
250	341.2	7/12/2005	EFW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search (USPAT; PGPUB) see search history	7/12/2005	EFW
PALM inventor name search	7/12/2005	EFW